

# IR2171

## LINEAR CURRENT SENSING IC

### Features

- Floating channel up to +600V
- Monolithic integration
- Linear current feedback through shunt resistor
- Direct digital PWM output for easy interface
- Low IQBS allows the boot strap power supply
- High Common Mode Noise Immunity
- Input overvoltage Protection for IGBT short circuit condition
- Open Drain output

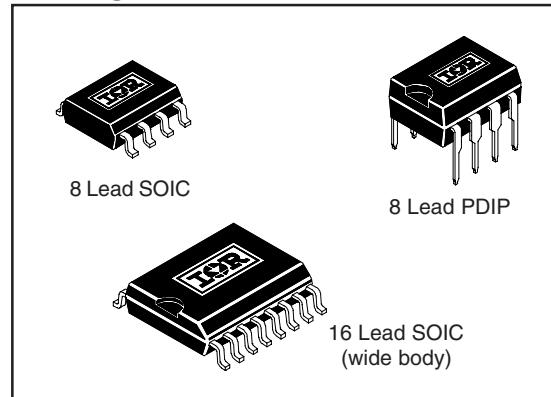
### Product Summary

$V_{OFFSET}$	600V
$I_{QBS}$	1mA
$V_{in}$	+/-260mVmax
Gain temp. drift	20ppm/ $^{\circ}\text{C}$ (typ.)
$f_o$	40kHz (typ.)

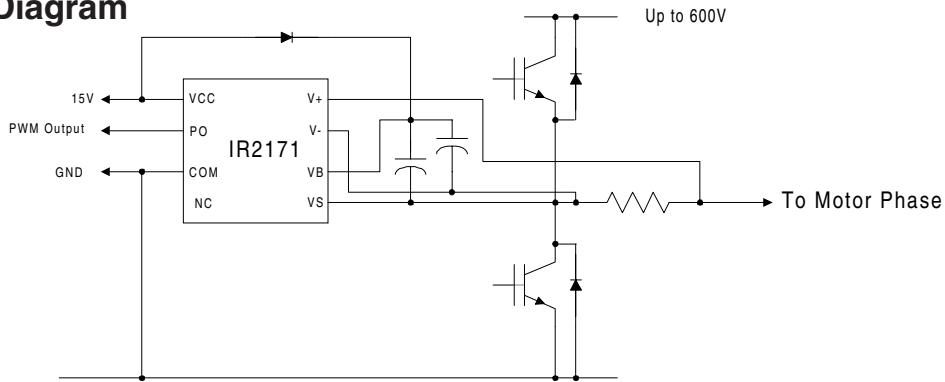
### Descriptions

IR2171 is the linear current sensing IC designed for motor drive applications. It senses the motor phase current through an external shunt resistor, converts from analog to digital signal, and transfers the signal to the low side. IR's proprietary high voltage isolation technology is implemented to enable the high bandwidth signal processing. The output format is discrete PWM at 40kHz to eliminate need for the A/D input interface. It allows direct interface to uP via simple counter based measurement. The independently powered output enables easy interface to the opto coupler device for galvanic isolation if needed.

### Packages



### Block Diagram



**Absolute Maximum Ratings**

Absolute maximum ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to COM, all currents are defined positive into any lead. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions.

Symbol	Definition	Min.	Max.	Units
$V_S$	High side offset voltage	-0.3	600	V
$V_{BS}$	High side floating supply voltage	$V_S - 0.3$	25	
$V_{CC}$	Low side and logic fixed supply voltage	-0.3	25	
$V_{IN}$	Maximum input voltage between $V_{IN+}$ and $V_{IN-}$	-5	5	
$V_{PO}$	Digital PWM output voltage	COM -0.3	$V_{CC} + 0.3$	
$V_{IN-}$	$V_{IN-}$ input voltage (note 1)	$V_S - 5$	$V_B + 0.3$	
$dV/dt$	Allowable offset voltage slew rate	—	50	V/ns
$P_D$	Package power dissipation @ $T_A \leq +25^\circ\text{C}$	8 lead SOIC	—	.625
		8 lead PDIP	—	1.0
		16 lead SOIC	—	1.25
$R_{thJA}$	Thermal resistance, junction to ambient	8 lead SOIC	—	200
		8 lead PDIP	—	125
		16 lead SOIC	—	100
$T_J$	Junction temperature	—	150	$^\circ\text{C}$
$T_S$	Storage temperature	-55	150	
$T_L$	Lead temperature (soldering, 10 seconds)	—	300	

Note 1: Capacitors are required between  $V_B$  and  $V_{IN-}$ , and between  $V_B$  and  $V_S$  pins when bootstrap power is used. The external power supply, when used, is required between  $V_B$  and  $V_{IN-}$ , and between  $V_B$  and  $V_S$  pins.

**Recommended Operating Conditions**

The output logic timing diagram is shown in figure 1. For proper operation the device should be used within the recommended conditions.

Symbol	Definition	Min.	Max.	Units
$V_B$	High side floating supply voltage	$V_S + 13.0$	$V_S + 20$	V
$V_S$	High side floating supply offset voltage	note 2	600	
$V_{PO}$	Digital PWM output voltage	COM	$V_{CC}$	
$V_{CC}$	Low side and logic fixed supply voltage	9.5	20	
$V_{IN}$	Input voltage between $V_{IN+}$ and $V_{IN-}$	-260	+260	mV
$T_A$	Ambient temperature	-40	125	$^\circ\text{C}$

Note 2: Logic operation for  $V_S$  of -5 to +600V. Logic state held for  $V_S$  of -5V to  $-V_{BS}$ .

## DC Electrical Characteristics

V<sub>CC</sub> = V<sub>BS</sub> = 15V, unless otherwise specified.

Symbol	Definition	Min.	Typ.	Max.	Units	Test Conditions
V <sub>IN</sub>	Nominal input voltage range before saturation  V <sub>IN+</sub> – V <sub>IN-</sub>	-260	—	260	mV	V <sub>IN</sub> = 0V (Note 1)
V <sub>OS</sub>	Input offset voltage	-10	0	10		
ΔV <sub>OS</sub> /ΔT <sub>A</sub>	Input offset voltage temperature drift	—	25	—	μV/°C	
G	Gain (duty cycle % per V <sub>IN</sub> )	157	162	167	%/V	max gain error=5% (Note 2)
ΔG/ΔT <sub>A</sub>	Gain temperature drift	—	20	—	ppm/°C	
I <sub>LK</sub>	Offset supply leakage current	—	—	50	μA	V <sub>B</sub> = V <sub>S</sub> = 600V
I <sub>QBS</sub>	Quiescent V <sub>BS</sub> supply current	—	1	2	mA	V <sub>S</sub> = 0V
I <sub>QCC</sub>	Quiescent V <sub>CC</sub> supply current	—	—	1		
LIN	Linearity (duty cycle deviation from ideal linearity curve)	—	0.5	1	%	
ΔLIN/ΔT <sub>A</sub>	Linearity temperature drift	—	.005	—	%/°C	
I <sub>O-</sub>	Output sink current	20	—	—	mA	V <sub>O</sub> = 1V
		2	—	—		V <sub>O</sub> = 0.1V

Note 1: ±10mV offset represents ±1.5% duty cycle fluctuation

Note 2: Gain = (full range of duty cycle in %) / (full input voltage range).

## AC Electrical Characteristics

V<sub>CC</sub> = V<sub>BS</sub> = 15V, unless otherwise specified.

Symbol	Definition	Min.	Typ.	Max.	Units	Test Conditions
<b>Propagation delay characteristics</b>						
f <sub>o</sub>	Carrier frequency output	—	40	—	kHz	figure 1
Δf/ΔT <sub>A</sub>	Temperature drift of carrier frequency	—	500	—	ppm/°C	V <sub>IN</sub> = 0V & 5V
D <sub>min</sub>	Minimum duty	—	7	—	%	V <sub>IN+</sub> =-260mV, V <sub>IN-</sub> =0
D <sub>max</sub>	Maximum duty	—	93	—	%	V <sub>IN+</sub> =+260mV, V <sub>IN-</sub> =0
BW	f <sub>o</sub> bandwidth		15		kHz	V <sub>IN+</sub> =100mV pk-pk sine wave, -3dB
PHS	Phase shift at 1kHz		-10		°	V <sub>IN+</sub> =100mVpkpk sine wave

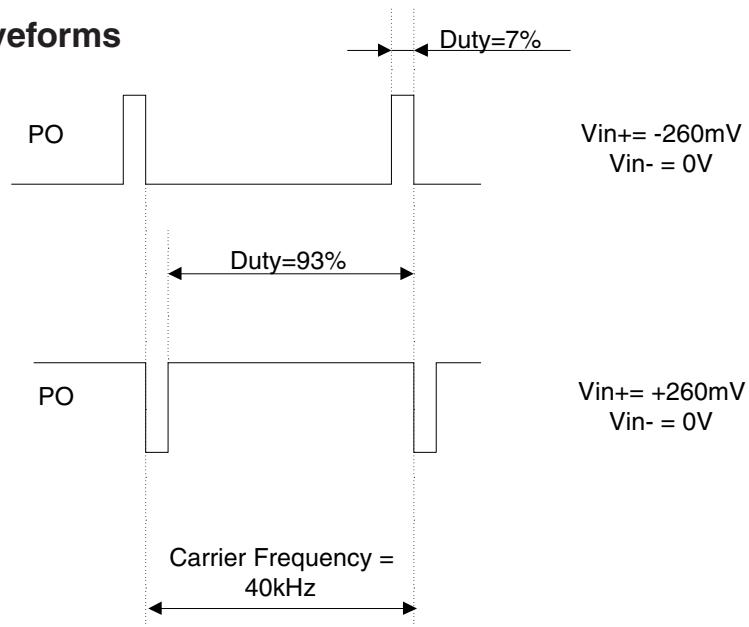
**Timing Waveforms**

Figure 1 Output waveform

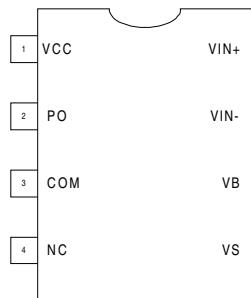
**Application Hint:**

Temperature drift of the output carrier frequency can be cancelled by measuring both a PWM period and the on-time of PWM (Duty) at a same time. Since both periods vary in the same direction, computing the ratio between these values at each PWM periods gives consistent measurement of the current feedback over the temperature drift.

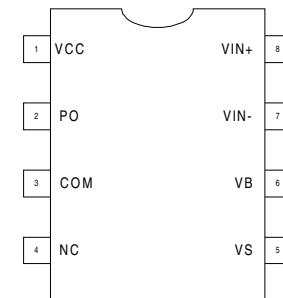
## Lead Definitions

Symbol	Description
VCC	Low side and logic supply voltage
COM	Low side logic ground
VIN+	Positive sense input
VIN-	Negative sense input
VB	High side supply
VS	High side return
PO	Digital PWM output
N.C.	No connection

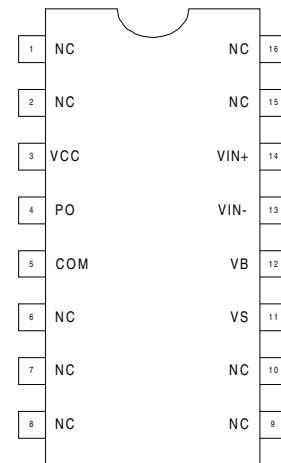
## Lead Assignment



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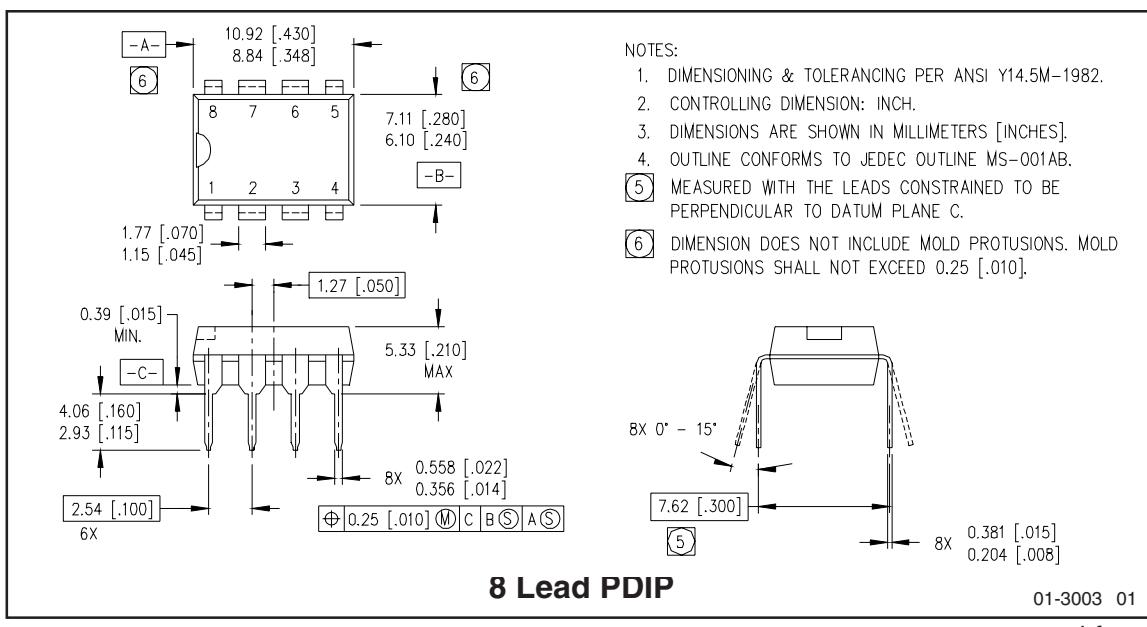
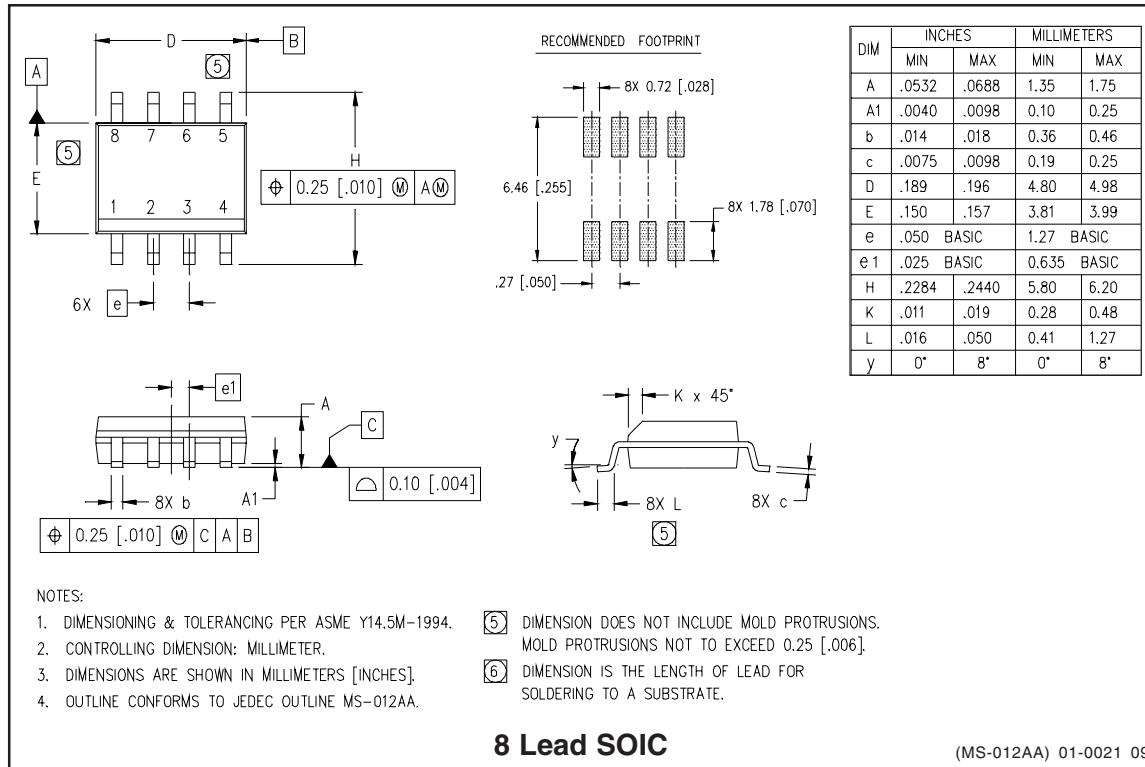


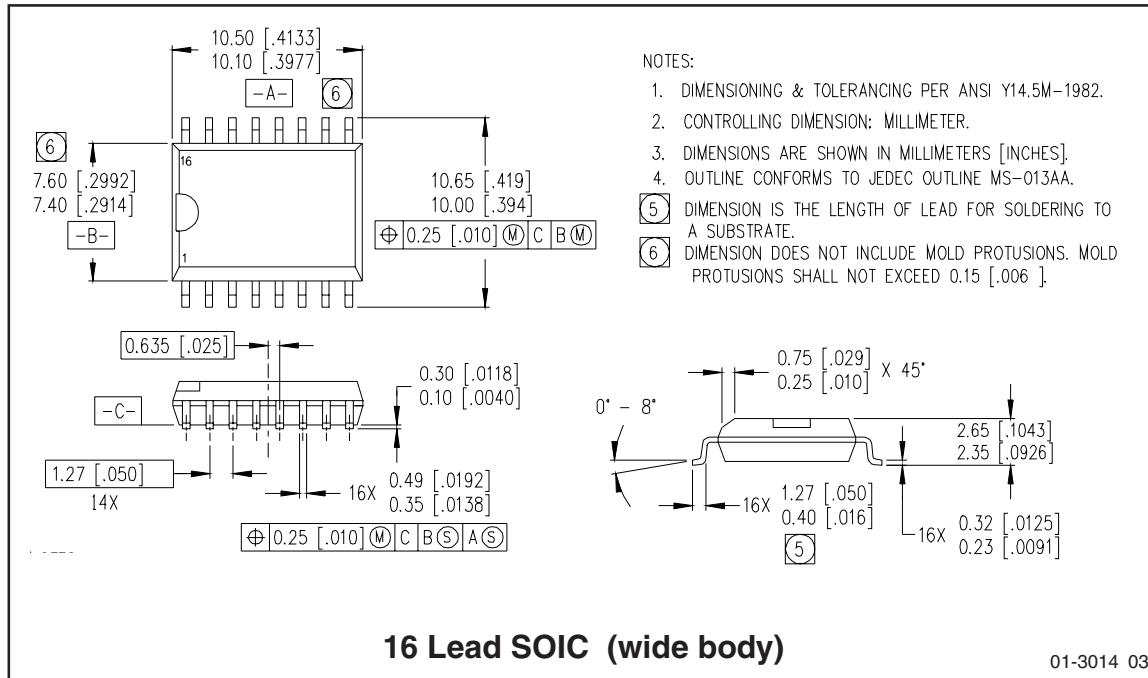
IR2171



IR21716S

## Case Outline





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